

MOS INTEGRATED CIRCUIT μ PD16311

1/8- to 1/16-DUTY FIP™ (VFD) CONTROLLER/DRIVER

The μ PD16311 is a FIP (Fluorescent Indicator Panel or Vacuum Fluorescent Display) controller/driver that is driven on a 1/8- to 1/16 duty factor. It consists of 12 segment output lines, 8 grid output lines, 8 segment/grid output drive lines, a display memory, a control circuit, and a key scan circuit. Serial data is input to the μ PD16311 through a three-line serial interface. This FIP controller/driver is ideal as a peripheral device of a single-chip microcomputer.

FEATURES

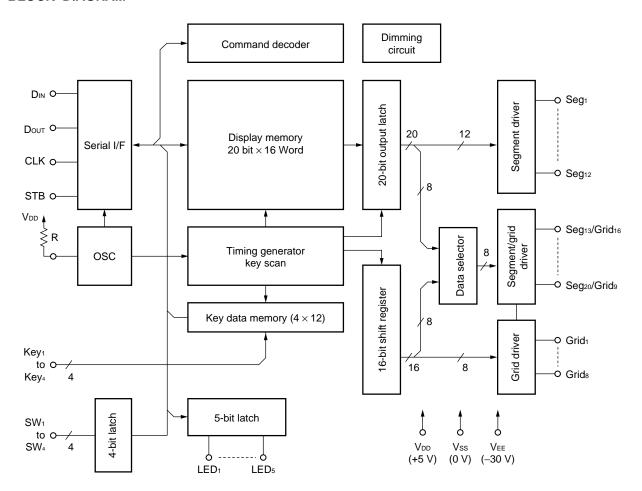
- Many display modes (12-segment & 16-digit to 20-segment & 8-digit)
- Key scanning (12 × 4 matrices)
- Dimming circuit (eight steps)
- High-voltage output (VDD 35 V max).
- LED ports (5 chs., 20 mA max).
- General-purpose input port (4 bits)
- · No external resistor necessary for driver outputs (P-ch open-drain + pull-down resistor output)
- Serial interface (CLK, STB, DIN, DOUT)

ORDERING INFORMATION

Part Number	Package
μPD16311GC-AB6	52-pin plastic QFP (∐14)

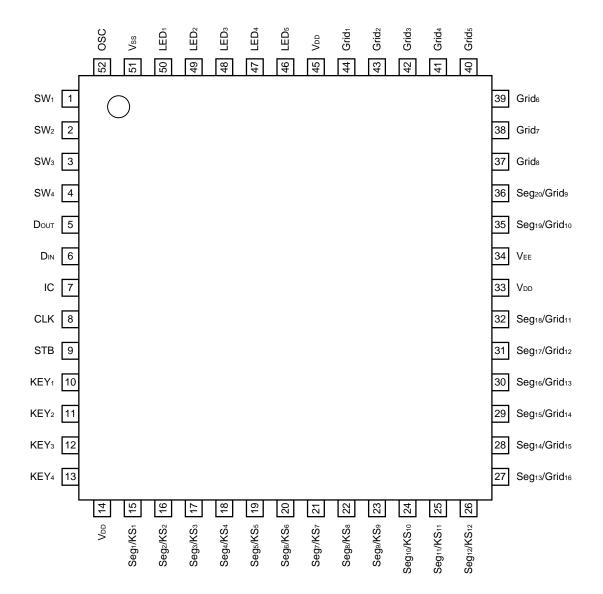


BLOCK DIAGRAM





PIN CONFIGURATION (Top View)



Use all the power pins. Leave the IC pin open.



Pin Function

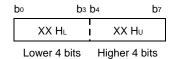
Pin No.	Symbol	Pin Name	Description
6	Din	Data input	Inputs serial data at rising edge of shift clock, starting from lower bit.
5	Dоит	Data output	Outputs serial data at falling edge of shift clock, starting from lower bit. This is N-ch open-drain output pin.
9	STB	Strobe	Initializes serial interface at rising or falling edge to make μ PD16311 waiting for reception of command. Data input after STB has fallen is processed as command. While command data is processed, current processing is stopped, and serial interface is initialized. While STB is high, CLK is ignored.
8	CLK	Clock input	Reads serial data at rising edge, and outputs data at falling edge.
52	OSC	Oscillator pin	Connect resistor for determining oscillation frequency to this pin.
15 to 26	Seg ₁ /KS ₁ to Seg ₁₂ /KS ₁₂	High-voltage output (segment)	Segment output pins (Dual function as key source)
44 to 37	Grid₁ to Grid6	High-voltage output (grid)	Grid output pins
27 to 32 35 to 36	Seg13/Grid16 to Seg20/Grid9	High-voltage output (segment/grid)	These pins are selectable for segment or grid output.
50 to 46	LED ₁ to LED ₅	LED output	CMOS output. +20 mA max.
10 to 13	Key ₁ to Key ₄	Key data input	Data input to these pins is latched at end of display cycle.
1 to 4	SW ₁ to SW ₄	Switch input	These pins constitute 4-bit general-purpose input port.
14, 33, 45	VDD	Logic power	5 V ± 10 %
51	Vss	Logic ground	Connect this pin to GND of system.
34	VEE	Pull-down level	V _{DD} – 35 V max.
7	IC	Internally connected	Be sure to leave this pin open (this pin is at VDD level).



Display RAM Address and Display Mode

The display RAM stores the data transmitted from an external device to the μ PD16311 through the serial interface, and is assigned addresses as follows, in units of 8 bits:

Seg ₁	Seg ₄	Seg ₈	Seg ₁₂	Seg ₁₆	Seg ₂₀)
00 HL	. !	00 H ∪	01 H∟	01 H ∪	02 H∟	DIG₁
03 HL	. !	03 H ∪	04 H∟	04 H ∪	05 H∟	DIG ₂
06 HL	. !	06 H ∪	07 H∟	07 H ⊍	08 H∟	DIG₃
09 HL		09 H ∪	0 AHL	0 AH ∪	0 BH∟	DIG ₄
0 CH	- I	0 CH∪	0 DH∟	0 DH ∪	0 EH∟	DIG₅
0 FHL		0 FH∪	10 H∟	10 H ∪	11 H∟	DIG ₆
12 HL	. !	12 H∪	13 H∟	13 H ∪	14 H∟	DIG ₇
15 HL	. !	15 H∪	16 H∟	16 H ∪	17 H∟	DIG ₈
18 HL	. !	18 H∪	19 H∟	19 H ∪	1 AH∟	DIG9
1 BH	. !	1 BH∪	1 CH∟	1 CH∪	1 DHL	DIG ₁₀
1 EHL	. <u>!</u>	1 EH∪	1 FH∟	1 FH∪	20 H∟	DIG ₁₁
21 HL	. !	21 H ∪	22 H∟	22 H ∪	23 H∟	DIG12
24 HL	. <u>I</u>	24 H∪	25 H∟	25 H ∪	26 H∟	DIG ₁₃
27 HL	. !	27 H ∪	28 H∟	28 H ∪	29 H∟	DIG ₁₄
2 AHL	. !	2 AH∪	2 BH∟	2 BH ∪	2 CHL	DIG ₁₅
2 DH	- I	2 DH∪	2 EH∟	2 EH∪	2 FH∟	DIG ₁₆

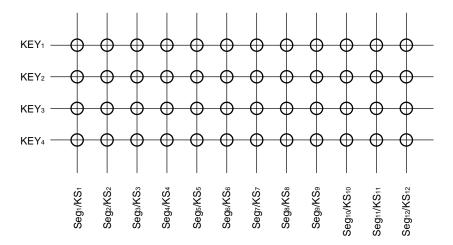


Only the lower 4 bits of the addresses assigned to Seg₁₇ through Seg₂₀ are valid, and the higher 4 bits are ignored.



Key Matrix and Key-Input Data Storage RAM

The key matrix is of 12×4 configuration, as shown below.



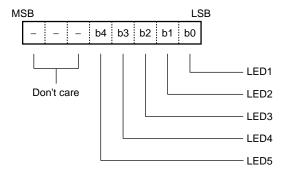
The data of each key is stored as illustrated below, and is read by a read command, starting from the least significant bit.

KEY ₁ KEY ₄	KEY1KEY4	_
Seg ₁ /KS ₁	Seg ₂ /KS ₂	1
Seg ₃ /KS ₃	Seg ₄ /KS ₄	
Seg₅/KS₅	Seg ₆ /KS ₆	
Seg ₇ /KS ₇	Segs/KSs	
Seg ₉ /KS ₉	Seg10/KS10	
Seg11/KS11	Seg ₁₂ /KS ₁₂	Reading sequence
b0 b3	b4b7	•

When the most significant bit of data (Seg₁₂ b₇) has been read, the least significant bit of the next data (Seg₁ b₀) is read.

LED Port

Data is written to the LED port by a write command, starting from the least significant bit of the port. When a bit of this port is 0, the corresponding LED lights; when the bit is 1, the LED goes off. The data of bits 6 through 8 is ignored.

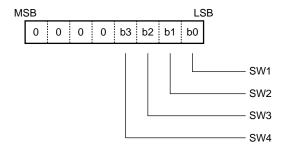


On power application, all the LEDs remain dark.



SW Data

The SW data is read by a read command, starting from the least significant bit. Bits 5 through 8 of the SW data are 0.



Command

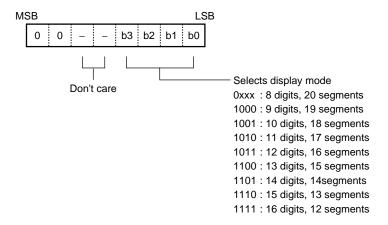
A command sets the display mode and status of the FIP driver.

The first 1 byte input to the μ PD16311 through the D_{IN} pin after the STB pin has fallen is regarded as a command. If STB is made high while a command/data is transmitted, serial communication is initialized, and the command/data being transmitted is invalid (however, the command/data already transmitted remains valid).

(1) Display mode setting command

This command initializes the μ PD16311 and selects the number of segments and number of grids (1/8 to 1/16 duty, 12 segments to 20 segments).

When this command is executed, display is forcibly turned off, and key scanning is also stopped. To resume display, a display ON command must be executed. If the same mode is selected, however, nothing is performed.

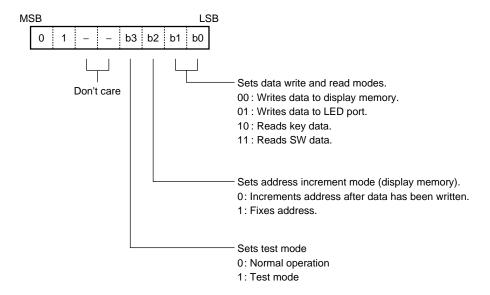


On power application, the 16-digit, 12-segment mode is selected.



(2) Data setting command

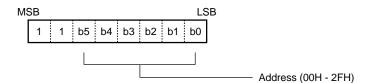
This command sets data write and data read modes.



On power application, the normal operation mode and address increment mode are set.

(3) Address setting command

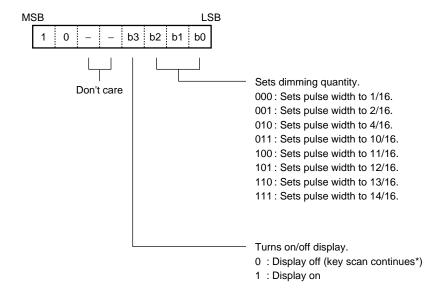
This command sets an address of the display memory.



If address 30H or higher is set, the data is ignored, until a correct address is set.

On power application, the address is set to 00H.

(4) Display control command

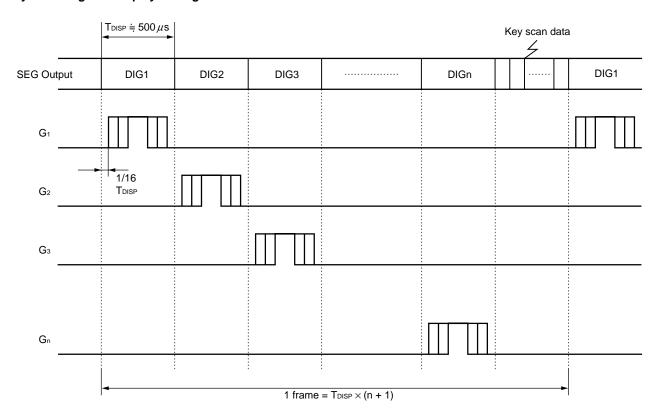


On power application, the 1/16-pulse width is set and the display is turned off.

^{*:} On power application, key scanning is stopped.



Key Scanning and Display Timing

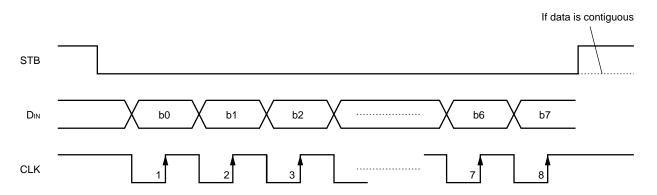


One cycle of key scanning consists of two frames, and data of 12×4 matrices is stored in RAM.

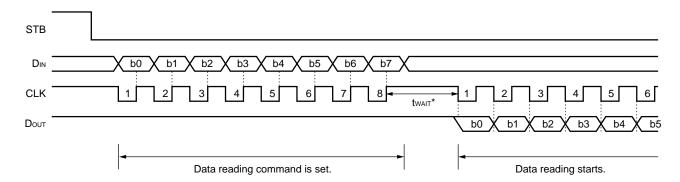


Serial Communication Format

Reception (command/data write)



Transmission (data read)



Because the DouT pin is an N-ch, open-drain output pin, be sure to connect an external pull-up resistor to this pin (1 k Ω to 10 k Ω).

*: When data is read, a wait time twart of 1 μ s is necessary since the rising of the eighth clock that has set the command, until the falling of the first clock that has read the data.



ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C, Vss = 0 V)

PARAMETER	SYMBOL	RATINGS	UNIT
Logic Supply Voltage	V _{DD}	-0.5 to +7.0	V
Driver Supply Voltage	VEE	V _{DD} +0.5 to V _{DD} -40	V
Logic Input Voltage	Vıı	-0.5 to V _{DD} +0.5	V
FIP Driver Output Voltage	Vo ₂	VEE -0.5 to VDD +0.5	٧
LED Driver Output Current	l ₀₁	+25	mA
FIP Driver Output Current	l 02	-40 (grid) -15 (segment)	mA
Power Dissipation	Po	1200*	mW
Operating Ambient Temperature	Topt	-40 to +85	°C
Storage Temperature	T _{stg}	-65 to +150	°C

^{*:} Derate at -9.6 mW/°C at $T_a = 25$ °C or higher.

RECOMMENDED OPERATING CONDITIONS (Ta = -20 to +70 °C, Vss = 0 V)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Logic Supply Voltage	V _{DD}	4.5	5	5.5	V	
High-Level Input Voltage	VIH	0.7 • VDD		V _{DD}	V	
Low-Level Input Voltage	VIL	0		0.3 • V _{DD}	V	
Driver Supply Votlage	VEE	0		V _{DD} - 35	V	

Maximum power consumption P_{MAX} . = FIP driver dissipation + R_L dissipation + LED driver dissipation + dynamic power consumption

Where segment current = 3 mA, grid current = 15 mA, and LED current = 20 mA,

FIP driver dissipation = number of segments × 6 + number of grids/(number of grids + 1) × 30 (mW)

RL dissipation = $(V_{DD} - V_{EE})^2/50 \times (segment + 1) (mW)$

LED driver dissipation = number of LEDs \times 20 (mW)

Dynamic power consumption = $V_{DD} \times 5$ (mW)

Example

Where VEE = -30 V, VDD = 5 V, and in 16-segment and 12-digit modes,

FIP driver dissipation = $16 \times 6 + 12/13 \times 35 = 128$

R_L dissipation = $35^2/50 \times 17 = 417$

LED driver dissipation = $5 \times 20 = 100$

Dynamic power consumption = $5 \times 5 = 25$

Total 670 mW



ELECTRICAL SPECIFICATIONS ($T_a = -20 \text{ to } +70 \text{ °C}$, $V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$, $V_{SS} = 0 \text{ V}$, $V_{EE} = V_{DD} -35 \text{ V}$)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
High-Level Output Voltage	Voн1	0.9 V _{DD}			V	LED1 – LED5, Iон1 = –1 mA
Low-Level Output Voltage	V _{OL1}			1	٧	LED1 - LED5, IoL1 = 20 mA
Low-Level Output Voltage	V _{OL2}			0.4	V	Dout, lot2 = 4 mA
High-Level Output Current	І ОН21	-3			mA	Vo = VDD -2 V, Seg1 to Seg12
High-Level Output Current	І ОН22	-15			mA	Vo = VDD -2 V, Grid1 to Grid8, Seg13/ Grid16 to Seg12/ Grid9
Driver Leakage Current	loleak			-10	μA	Vo = VDD −35 V, driver off
Output Pull-Down Resistor	RL	50	100	150	ΚΩ	Driver output
Input Current	ļı.			±1	μΑ	VI = VDD or Vss
High-Level Input Voltage	VIH	0.7 V _{DD}			٧	
Low-Level Input Voltage	VIL			0.3 Vdd	V	
Hysteresis Voltage	Vн		0.35		V	CLK, D _{IN} , STB
Dynamic Current Consumption	IDDdyn			5	mA	Under no load, display off

SWITCHING CHARACTERISTICS ($T_a = -20 \text{ to } +70 \text{ °C}$, $V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$, $V_{EE} = -30 \text{ V}$)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Oscillation Frequency	tosc	350	500	650	kHz	R = 56 kΩ	
Propagation Delay Time	t PLZ			300	ns	CLK → Dout	
	t PZL			100	ns	$C_L = 15 \text{ pF}, R_L = 10 \text{ k}\Omega$	
Rise Time	t _{TZH1}			2	μS	C _L = 300 pF	Seg ₁ to Seg ₁₂
	t тzн2			0.5	μS		Grid1 to Grid8, Seg13/Grid16 to Seg20/Grid9
Fall time	tтнz			120	μS	CL = 300 pF, Segn, Gridn	
Maximum Clock Frequency	f _{max} .	1			MHz	Duty = 50 %	
Input Capacitance	Cı			15	pF		

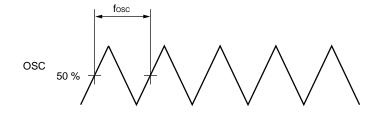
TIMING CONDITIONS ($T_a = -20 \text{ to } +70 \text{ °C}$, $V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$)

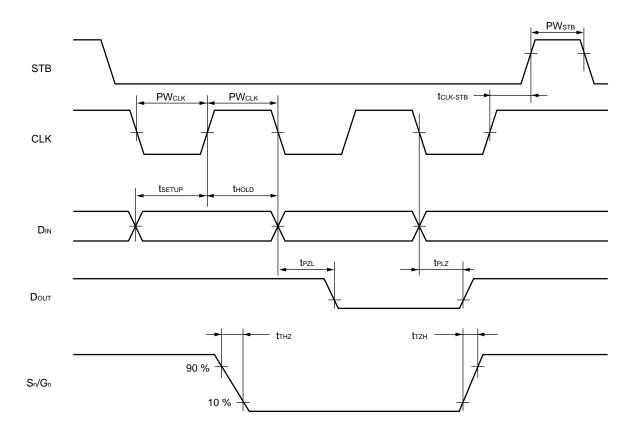
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Clock Pulse Width	PWclk	400			ns	
Strobe Pulse Width	PWstB	1			μS	
Data Setup Time	t SETUP	100			ns	
Data Hold Time	thold	100			ns	
Clock-Strobe Time	tclk-stb	1			μs	$CLK \uparrow \rightarrow STB \uparrow$
Wait Time	t wait	1			μS	$CLK \uparrow \rightarrow CLK \downarrow^*$

^{*:} Refer to page 11.



Switching Characteristic Waveform

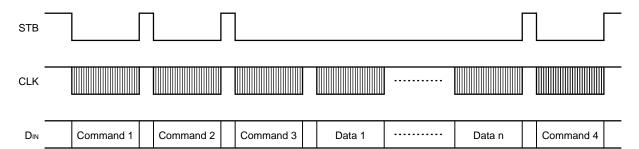






Applications

Updating display memory by incrementing address



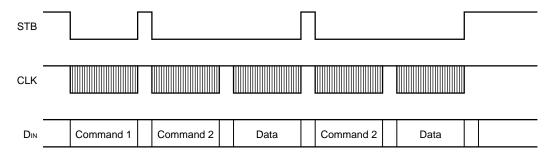
Command 1: sets display mode

Command 2: sets data
Command 3: sets address

Data 1 to n: transfers display data (48 bytes max.)

Command 4: controls diplay

Updating specific address



Command 1: sets data
Command 2: sets address
Data: display data



RECOMMENDED SOLDERING CONDITIONS

The following conditions (see table below) must be met when soldering this product. Please consult with our sales officers in case other soldering process is used or in case soldering is done under different conditions.

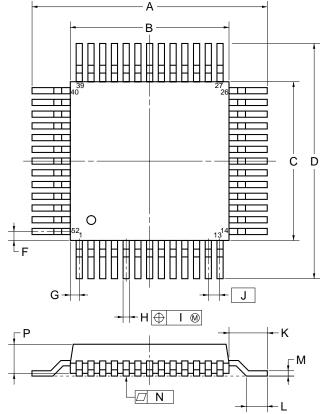
μ PD16311GC-AB6

Soldering process	Soldering conditions	Symbol
Infrared ray reflow	Peak package's surface temperature: 235 °C or below, Reflow time: 30 seconds or below (210 °C or higher), Number of reflow process: 2, Exposure limit*: None	IR35-00-2
VPS	Peak package's surface temperature: 215 °C or below, Reflow time: 40 seconds or below (200 °C or higher), Number of reflow process: 2, Exposure limit*: None	VP15-00-2
Wave soldering	Solder temperature: 260 °C or below, Flow time: 10 seconds or below, Number of flow process: 1, Exposure limit*: None	WS60-00-1
Partial heating method	Terminal temperature: 300 °C or below, Flow time: 10 seconds or below, Exposure limit*: None	

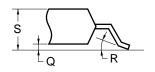
^{*} Exposure limit before soldering after dry-pack package is opened. Storage conditions: 25 °C and relative humidity at 65 % or less.

Note Do not apply more than a single process at once, except for "Partial heating method".

52 PIN PLASTIC QFP (14 \times 14)



detail of lead end



NOTE

Each lead centerline is located within 0.20 mm (0.008 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	17.6±0.4	0.693±0.016
В	14.0±0.2	0.551+0.009
С	14.0±0.2	$0.551^{+0.009}_{-0.008}$
D	17.6±0.4	0.693±0.016
F	1.0	0.039
G	1.0	0.039
Н	0.40±0.10	0.016 ^{+0.004} -0.005
I	0.20	0.008
J	1.0 (T.P.)	0.039 (T.P.)
K	1.8±0.2	$0.071^{+0.008}_{-0.009}$
L	0.8±0.2	0.031+0.009
М	$0.15^{+0.10}_{-0.05}$	$0.006^{+0.004}_{-0.003}$
N	0.10	0.004
Р	2.6	0.102
Q	0.1±0.1	0.004±0.004
R	5°±5°	5°±5°
S	3.0 MAX.	0.119 MAX.

P52GC-100-AB6-4

[MEMO]

[MEMO]

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Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

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